

10/588686

Express Mail Label No.: EV 908 858 **JP20 Rec'd PCT/PTO 07 AUG 2006**

IN THE U.S. PATENT AND TRADEMARK OFFICE

August 7, 2006

Applicants : Katsuyuki TSUCHIDA et al  
For : COPPER ELECTROLYTIC SOLUTION CONTAINING AS  
ADDITIVE COMPOUND HAVING SPECIFIC SKELETON,  
AND ELECTROLYTIC COPPER FOIL MANUFACTURED  
THEREWITH

PCT International Application No.: PCT/JP2005/022662

PCT International Filing Date: December 9, 2005

U.S. Application No.

(if known, see 37 CFR 1.5): Unknown

Atty. Docket No.: 4700.P0335US

Mail Stop PCT  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. These references are mentioned in Applicants' specification or listed on the International Search Report. Further comment at this point in time should not be necessary.

Respectfully submitted,

TFC/smd

  
Terryence F. Chapman

FLYNN, THIEL, BOUTELL	Dale H. Thiel	Reg. No. 24 323
& TANIS, P.C.	David G. Boutell	Reg. No. 25 072
2026 Rambling Road	Terryence F. Chapman	Reg. No. 32 549
Kalamazoo, MI 49008-1631	Mark L. Maki	Reg. No. 36 589
Phone: (269) 381-1156	Liane L. Churney	Reg. No. 40 694
Fax: (269) 381-5465	Brian R. Tumm	Reg. No. 36 328
	Steven R. Thiel	Reg. No. 53 685
	Donald J. Wallace	Reg. No. 43 977
	Sidney B. Williams, Jr.	Reg. No. 24 949

Encl: Copy of International Search Report  
Form PTO-1449 and one copy of each listed reference

INFORMATION  
DISCLOSURE  
CITATION

Applicant: KASHIMURA, TSUCHIDA et al

Ser. No.: Unknown

Conf. No.: Unknown

Group: Unknown

Filed: Unknown

Atty. Docket No.: 4700.P0335US

Date: August 7, 2006

10/588686  
AP29 Rec'd PCT/PTO 07 AUG 2006

## U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	JP 10-193505	07-28-1998	TAMIYA et al	Abstract
	AM	JP 2004-315945	11-11-2004	YOKOTA et al	Abstract
	AN	JP 2004-107786	04-08-2004	KUMAGAI et al	Abstract
	AO	JP 10-330983	12-15-1998	SANO et al	Abstract
	AP				

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.